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	ם	1	Document ID	Issue Date	Pages	Title	Current OR
			US 20020154321 A1	20021024	18	Multiple-level printhead using embedded high speed serial data and control link with on-board exposure clock generation	358/1.8
7	_×_		US 4282583 A	19810804	44	Microprogrammable processor control printer system 358/1.5	358/1.5
3	_×_		US 4179732 A	19791218	44	Microprogrammable processor control printer system 358/1.16	358/1.16
4	×		NN9407267	19940701	NA	Method for Adding an External Real Time Clock to a System Having an Internal Real Time Clock	
S	×		NB9406321	19940601	NA	JTAG Invalid State Off Chip Drive Protect Mechanism	
9	×		NB9306145	19930601		Open-Short Circuit Self Test	
7	×		NN8904367	19890401		Large System Diagnostics With Minimal Hardware	
	×		NB80123098	19801201		Tester for Signature Analysis Verification. December 1980.	

Current XRef	Retrieval Classif	Inventor	s	ပ	۵	7	m	4	r.	Image Doc. Displayed	PΤ
		Pham, Hieu T. et al.	×_							US 20020154321	
711/156		Khan; Sultan W. et al.							-	US 4282583	
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+			Gafford, Thomas Austin et al.	×							JS 20040225824	
7			Gafford, Thomas Austin et al.						·		US 20030120851	
m	710/119		Gafford; Thomas Austin et al.								JS 6154799	_
4	439/331		Ikeya; Kiyokazu				_				JS 6033235	
<b>.</b>	358/402; 358/407; 382/187; 382/188; 382/228; 382/229; 704/2; 704/3; 704/8;		Adler; Richard et al.								US 5812818	
9		•	Gafford; Thomas Austin et al.								US 5758109	
	710/2; 710/309; 710/316; 711/147		Gafford; Thomas Austin et al.								JS 5684966	
8		-	Gafford; Thomas A. et al.							_	US 5621899	
ტ.			Hyatt; Gilbert P.								US 5594908	
10	711/109		Hyatt; Gilbert P.								US 5537565	

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	356/4.01; 379/1.01; 455/115.3;										
11	455/161.3; 455/226.2;		Lemke; Kurt T. et al.	·····					<u> </u>	US 5398276	
	455/423; 455/67.13										
12	968/900; 968/DIG.1		Hyatt; Gilbert P.							US 4942516	-
13	968/900; 968/DIG.1		Hyatt; Gilbert P.							US 4896260	
14	235/382; 340/3.51; 340/5.28; 340/5.5		Ozer; Richard et al.						· 	US 4839640	
15			Hyatt; Gilbert P.					_		US 4829419	
16	365/222; 712/32; 968/900; 968/DIG.1		Hyatt; Gilbert P.				;	. <u>.</u>		US 4825364	
17	345/156; 345/475; 710/73		Hyatt; Gilbert P.					_		US 4686622	
18	700/180		Hyatt; Gilbert P.				-			US 4531182	
19	355/54; 396/548		Hyatt; Gilbert P.							US 4445776	
20			Hyatt; Gilbert P.							US 4396976	
21			Hyatt; Gilbert P.							US 4371923	
77			Hyatt; Gilbert P.							US 4370720	
23	700/184		Hyatt; Gilbert P.							US 4364110	

	n	1	Document ID	Issue Date	Pages	Title	Current OR
24	×		US 4120583 A	19781017	75	High registration photomask method and apparatus	355/86
25	×		US 3173542 A	19650316	13	Document handling device	209/534
26	×		US 2974199 A	19610307		Telephone paystation circuit with coin-accept control 379/146	379/146
77	×		US 2349304 A	19440523		Selective signaling system and apparatus	178/23R
28	×		US 2211116 A	19400813		Telephone system	379/239
59	×		US 1802643 A	19310428		Electrical meter-reading system	340/870.02

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24	355/132; 355/95; 700/192;		Hyatt; Gilbert P.							US 4120583	20583	
25	716/19 312/212; 902/7		SIMJIAN LUTHER G							US 3173542	73542	
76	194/202		BELLAMY JOHN I									
27	340/825.26		POTTS LOUIS M					_	_			
<b>58</b>			ANTHONY HENSLER BERNARD									
53	200/8R; 340/286.01; 340/870.19; 377/87; 379/106.03; 73/198		FLOYD GEORGE G									

	Search Terms
1	BOARD
7	BOARDS
8	CONTROLLER
4	CONTROLLERS
10	LATCH
9	LATCHED
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17	SIGNAL
18	SIGNALS
19	STORAGE
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1			US 5034686 A	19910723	36	Weapon interface system evaluation apparatus and method	324/537
2	_×_		US 2167675 A	19390801	9	Motor vehicle door lock	180/286

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102/206; 89/1.59; 89/1.819		Aspelin; David J.	_×_						3	US 5034686	
180/281; 292/144	-	JOSEPH PALMER							SS_	US 2167675	

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-	×		US 20050030891 A1	20050210	12	Method and apparatus to select an adaptation technique in a wireless network	370/229
7	×		US 20040096017 A1	20040520		Pre-corrupting reference signals with inter-symbol interference	375/343
_ო_	×		US 6823472 B1	20041123	10	Shared resource manager for multiprocessor computer system	714/10
_4_	_×_		JP 2003015824 A	20030117	6	HIGH BANDWIDTH STORAGE DEVICE ARCHITECTURE	
5	×.		EP 1271334 A2	20030102	6	High bandwidth storage device architecture	

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	370/310		Stephens, Adrian P. et al.	×							US 20050030891	
_7	375/340		Holt, Keith et al.	-							US 20040096017	
3	710/56		DeKoning; Rodney A. et al.								US 6823472	
4			HENRY, RUSSEL J et al.								JP 2003015824 A	
Ŋ			HENRY, RUSSEL J et al.							111	EP 1271334 A2	



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